

Characterisation & testing at LAL

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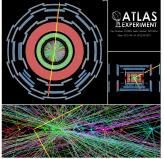
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Motivation







- \blacksquare HL-LHC phase II upgrade in \sim 2022
- Expected fluence of 10⁻¹⁶
 - Includes a new ATLAS tracker → requires improved pixel devices (radiation hard, slimmer edges, better granularity...).
- Results obtained from test structures can be used to develop reliable simulations of devices.
- Simulations, in turn, drive the development of new sensor layouts.
 - Quicker and less expensive than building multiple prototypes.

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What is LAL?

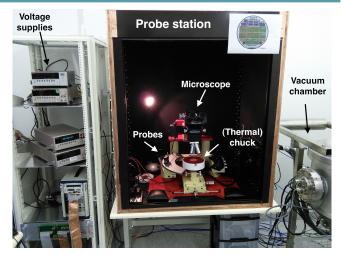
- Mixed research laboratory between CNRS and University Paris XI
- Situated at Orsay (south of Paris)
- Originally an accelerator laboratory, claiming first e-e⁻ collisions
- Several Physics Groups (ATLAS, LHCb, NeMO, PLANK, ILC)
- Roughly 200 people including researchers, PhD students & engineers



- group) **Abdenour Lounis**. Université Paris
- Sud (ATLAS LAL Pixel Group Leader)
- Nicoleta Dinu, Research Engineer
- Clara Nellist, Post-Doc
- Vagelis Gkougkousis, PhD Student
- Ahmed Bassalat, PhD Student (IBL at CERN)
- Aboud Falou, Research Engineer (IBL at CERN)

The clean room (salle blanche)



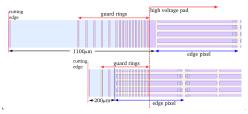


- Probe station works well.
- See IV results in Vagelis's talk.

Guard ring test structures



- Guard rings provide a controlled potential drop from the high voltage used for biasing the electrodes and the cutting edge of the device.
 - Usually this area is then inactive.
- Increasing the active area of pixel devices for future upgrades of ATLAS is important to minimise the material budget (therefore reduce scattering before the calorimeters).
 - For the IBL the dead area was reduced from ${\sim}1100~\mu{\rm m} \rightarrow 200~\mu{\rm m}$ by moving the edge pixels to partially underneath the guard rings.
 - Diodes with different numbers of guard rings were included in the wafer production for 2011.

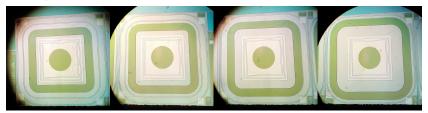


Diodes with varying numbers of guard rings. From 1-4.

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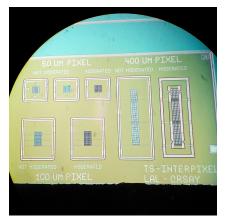


Diodes with varying numbers of guard rings. From 1-4.

Inter-pixel test structures



- Structures of various pixel size (50 μ m, 100 μ m and 400 μ m).
 - Each structure contains a central pixel, 8 surrounding pixels (connected together) and 16 outer pixels (also connected together).
- Can study the inter-pixel capacitance of various designs.



Omegapix



- Smaller pixel size of 50 x 50 μ m.
- Study of new, 3D read-out chips.
 - "an emerging, system level integration architecture wherein multiple strata (layers) of planar devices are stacked and interconnected using silicon (or other semiconductor material) vias (TSV) in the Z direction"¹

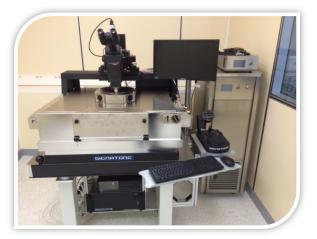


[1]: Handbook of 3D Integration, edited by Philip Garrou, Christopher Bower and Peter Ramm.

The clean room (salle blanche)



New probe station:



New clean 100 m^2 room construction combined with acquisition of semi-automatic testing system and wire bonding machine (CAPTINoV platform)

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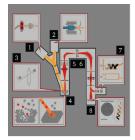
SIMS



SIMS system at Versailles (Cameca IMS 7F):



Already discussed by Vagelis. G in his talk yesterday: https://indico.cern.ch/ event/307015/session/7/contribution/30/material/slides/0.pdf



- Primary energetic ion beam (0.5-20 keV
- Depth resolution of 1 to 5 nm
- Destructive method

The Clean Room - test bench





- Setup the USBPix test bench.
 - Test devices with the laser and strontium-90 source (a β -source) with external triggering.
 - Requires scintillators with photomultiplier tubes these have arrived from CERN (see next photo).
 - NOTE: photo above is from before the setup was completed (looks tidier now!)

Laser System



- Pulse generator Agilent 81104A
- Built at CERN by Maurice Glaser
- Wavelength: 1068nm (close infra-red)
- Power output at 1.72 V = 0.592 mW
- New lens required.







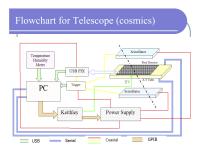




- The scintillators and photomultiplier tubes are from CERN.
- The final cabling has been performed at LAL.
- Two scintillators required. Three purchased / assembled to allow for redundancy in case of issues.



We had a master's student (D. Hohov) at LAL who wrote LabView code to automate the test bench setup.





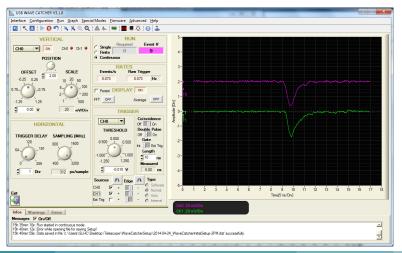
Diagrams by D. Hohov.

Trigger - wavecatcher



Input is an analogue signal from the scintillators.

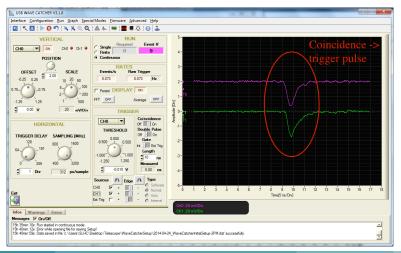
Output as a digital trigger pulse.



Trigger - wavecatcher

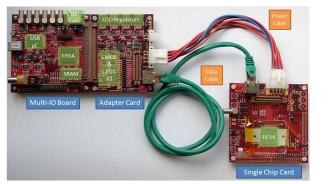


- Input is an analogue signal from the scintillators.
- Output as a digital trigger pulse.



Laboratory Characterisation





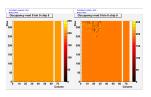


- USBPix is used to characterise the sensors.
 - Few hardware components, modular and portable.
- Data analysis using STcontrol software.

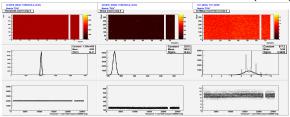
Laboratory Characterisation



Analogue and digital:



Threshold, noise and Time Over Threshold (TOT):





 This is understood and requires changing the Efuse_Cref parameter during the tuning. How TOT and Threshold tuning effects the results.

high threshold — high feedback

threshold

dependence

iteedback current

TOT tuning could be better, but since this is just for proof of principle, it is fine for now.

interted charge

dependence

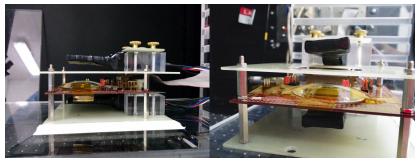
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preamplifier output signal

threshold -

Source scans - setup



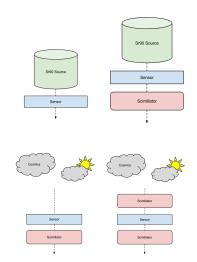


- One scintillator above and one below.
- Top scintillator can be removed to place the source as close to the sensor as possible.
- Collimator plates are under production to focus the source beam to a small number of pixels.



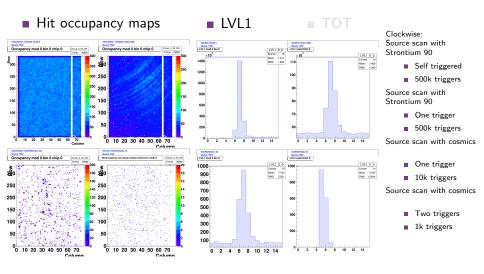
Performed scans with six different setups: First four at perpendicular angles:

- 1. Source scan with Strontium 90
 - Self triggered
 - 500k triggers
- 2. Source scan with Strontium 90
 - One trigger
 - 500k triggers
- 3. Source scan with cosmics
 - One trigger
 - 10k triggers
- 4. Source scan with cosmics
 - Two triggers
 - 1k triggers



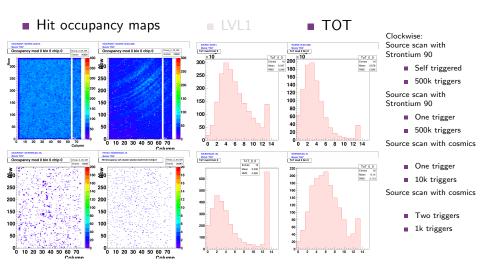
Source scan results





Source scan results





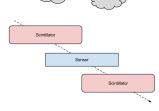
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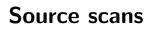
- 1. Source scan with cosmics
 - Two triggers
 - 500 triggers
 - Each scintillator overlaps half of the sensor
 - Data taking time $= \sim 1$ day
- 2. Source scan with cosmics
 - Two triggers
 - 500 triggers
 - Neither scintillator overlaps the sensor
 - Data taking time = \sim 2 days





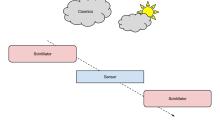


Cosmics



Source scans

- 1. Source scan with cosmics
 - Two triggers
 - 500 triggers
 - Each scintillator overlaps half of the sensor
 - \blacksquare Data taking time = \sim 1 day
- 2. Source scan with cosmics
 - Two triggers
 - 500 triggers
 - Neither scintillator overlaps the sensor
 - Data taking time = \sim 2 days







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Occupancy mod 0 bin 0 chip 0

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SOURCE SCAN 100

ToT med 8 bin 8

300

250

200

150

100

50

LVL1 0 0 18 350

Source scan results

SOURCE SCAN 100

LVL1 mod 0 bin 0

Column

- ToT_0_0 Entries 16 sensor 10 12 14 2 8
 - Source scan with cosmics
 - Two triggers

Source scan with cosmics

Two triggers

500 triggers

Neither scintillator

overlaps the sensor

- 500 triggers
- Each scintillator overlaps half of the

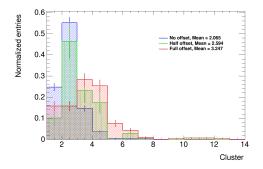
sounce_sow 50URCE_50A Noclate 'TD4' LVL1 mod 0 bin 0 9 nid 9 bom ToT Hit Occupancy (of cluster seeds) mod 0 bin 0 chip 0 LVL1_0_0 ToT_0_0 Entries 1 240 220 200 180 160 140 120 100 80 60 40 20 0 30 40 70 2 4 6 8 10 12 14 8 10 12 14 4 6 Column







Cluster Size as function of scintillator offset:



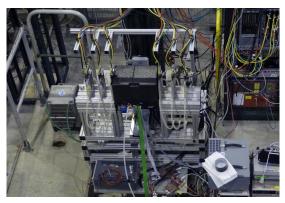
Increase of cluster size as scintillator gap is increased (as expected).

- With thanks to Marco B. for sharing his adaption of Christian G.'s clustering programme. Now work offline & offsite, which is great for us Windows-challenged (Mac) people.
- More people want to do these studies, please contact me to discuss.

Future Plans



- Test beam measurements with CiS modules with alternative bias rail layouts and with the new production when it arrives (hello Marco - I will send you an email!).
- Afterwards, irradiate modules and retest.



Summary



- The setup is working well and taking sensible data.
- The triggering system is good and the data rate is as expected.
- Can take cosmic scans at angles.
 - Limited by time. Since the greater the offset of the scintillators, the lower the data taking rate.
 - Intend to implement a tilt to the xy-table to achieve same results with increased rate, but this increases the distance of the scintillators from the device.
- There are a few issues with data loss from power cuts and computer issues
 - since the data taking period can be very long, using the source instead of replying on cosmics is a faster solution.
- The next stage is to finalise the setup with the laser system (new fibre optic cable required) and develop a TCT system.
- Then the setup can be used with other FE-I4 devices and especially irradiated devices.



Thank you for your attention



Any questions?

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Backup

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